

N-channel 650 V, 0.42 Ω typ., 8 A MDmesh™ M2 Power MOSFET in a TO-220 package

Datasheet - production data

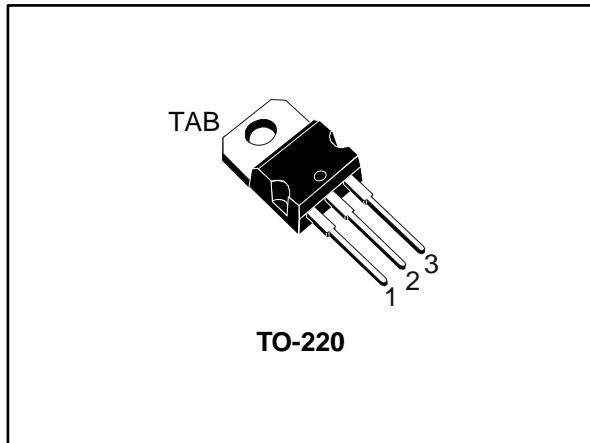
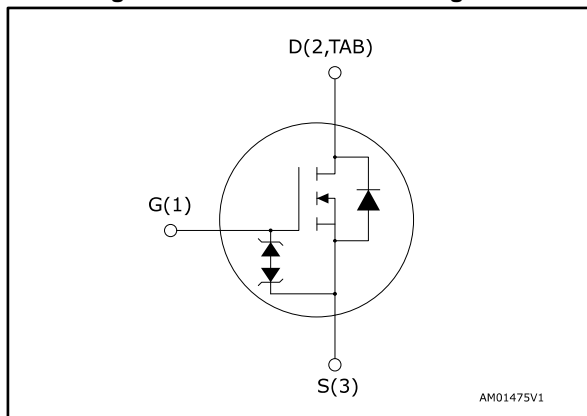


Figure 1: Internal schematic diagram



Features

| Order code | V _{DS} | R _{DS(on)} max. | I _D |
|------------|-----------------|--------------------------|----------------|
| STP12N65M2 | 650 V | 0.50 Ω | 8 A |

- Extremely low gate charge
- Excellent output capacitance (C_{oss}) profile
- 100% avalanche tested
- Zener-protected

Applications

- Switching applications

Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

| Order code | Marking | Package | Packing |
|------------|---------|---------|---------|
| STP12N65M2 | 12N65M2 | TO-220 | Tube |

Contents

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|--|------------|------------------|
| V_{GS} | Gate-source voltage | ± 25 | V |
| I_D | Drain current (continuous) at $T_{case} = 25\text{ }^\circ\text{C}$ | 8 | A |
| | Drain current (continuous) at $T_{case} = 100\text{ }^\circ\text{C}$ | 5 | |
| $I_{DM}^{(1)}$ | Drain current (pulsed) | 32 | A |
| P_{TOT} | Total dissipation at $T_{case} = 25\text{ }^\circ\text{C}$ | 85 | W |
| $dv/dt^{(2)}$ | Peak diode recovery voltage slope | 15 | V/ns |
| $dv/dt^{(3)}$ | MOSFET dv/dt ruggedness | 50 | |
| T_{stg} | Storage temperature range | -55 to 150 | $^\circ\text{C}$ |
| T_j | Operating junction temperature range | | |

Notes:

(1) Pulse width is limited by safe operating area.

(2) $I_{SD} \leq 8\text{ A}$, $di/dt = 400\text{ A}/\mu\text{s}$, $V_{DS(peak)} < V_{(BR)DSS}$, $V_{DD} = 400\text{ V}$

(3) $V_{DS} \leq 520\text{ V}$

Table 3: Thermal data

| Symbol | Parameter | Value | Unit |
|----------------|-------------------------------------|-------|---------------------------|
| $R_{thj-case}$ | Thermal resistance junction-case | 1.47 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-amb}$ | Thermal resistance junction-ambient | 62.5 | |

Table 4: Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|----------|--|-------|------|
| I_{AR} | Avalanche current, repetitive or non-repetitive (pulse width limited by $T_{jmax.}$) | 1.6 | A |
| E_{AS} | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$, $I_D = I_{AR}$, $V_{DD} = 50\text{ V}$) | 250 | mJ |

2 Electrical characteristics

($T_{\text{case}} = 25\text{ °C}$ unless otherwise specified)

Table 5: Static

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------|-----------------------------------|--|------|------|----------|---------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source breakdown voltage | $V_{\text{GS}} = 0\text{ V}$, $I_{\text{D}} = 1\text{ mA}$ | 650 | | | V |
| I_{DSS} | Zero-gate voltage drain current | $V_{\text{GS}} = 0\text{ V}$, $V_{\text{DS}} = 650\text{ V}$ | | | 1 | μA |
| | | $V_{\text{GS}} = 0\text{ V}$, $V_{\text{DS}} = 650\text{ V}$, $T_{\text{case}} = 125\text{ °C}^{(1)}$ | | | 100 | |
| I_{GSS} | Gate-body leakage current | $V_{\text{DS}} = 0\text{ V}$, $V_{\text{GS}} = \pm 25\text{ V}$ | | | ± 10 | μA |
| $V_{\text{GS(th)}}$ | Gate threshold voltage | $V_{\text{DS}} = V_{\text{GS}}$, $I_{\text{D}} = 250\text{ }\mu\text{A}$ | 2 | 3 | 4 | V |
| $R_{\text{DS(on)}}$ | Static drain-source on-resistance | $V_{\text{GS}} = 10\text{ V}$, $I_{\text{D}} = 4\text{ A}$ | | 0.42 | 0.50 | Ω |

Notes:

⁽¹⁾Defined by design, not subject to production test.

Table 6: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------------|-------------------------------|--|------|------|------|-------------|
| C_{iss} | Input capacitance | $V_{\text{DS}} = 100\text{ V}$, $f = 1\text{ MHz}$, $V_{\text{GS}} = 0\text{ V}$ | - | 535 | - | pF |
| C_{oss} | Output capacitance | | - | 25 | - | |
| C_{rss} | Reverse transfer capacitance | | - | 1.1 | - | |
| $C_{\text{oss eq.}}^{(1)}$ | Equivalent output capacitance | $V_{\text{DS}} = 0\text{ to }520\text{ V}$, $V_{\text{GS}} = 0\text{ V}$ | - | 144 | - | pF |
| R_{G} | Intrinsic gate resistance | $f = 1\text{ MHz}$, $I_{\text{D}} = 0\text{ A}$ | - | 7 | - | Ω |
| Q_{g} | Total gate charge | $V_{\text{DD}} = 520\text{ V}$, $I_{\text{D}} = 8\text{ A}$, $V_{\text{GS}} = 0\text{ to }10\text{ V}$ (see Figure 15: "Test circuit for gate charge behavior") | - | 16.7 | - | nC |
| Q_{gs} | Gate-source charge | | - | 2.6 | - | |
| Q_{gd} | Gate-drain charge | | - | 8.6 | - | |

Notes:

⁽¹⁾ $C_{\text{oss eq.}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 7: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------------|---------------------|--|------|------|------|-------------|
| $t_{\text{d(on)}}$ | Turn-on delay time | $V_{\text{DD}} = 325\text{ V}$, $I_{\text{D}} = 4\text{ A}$ $R_{\text{G}} = 4.7\text{ }\Omega$, $V_{\text{GS}} = 10\text{ V}$ (see Figure 14: "Test circuit for resistive load switching times" and Figure 19: "Switching time waveform") | - | 9 | - | ns |
| t_{r} | Rise time | | - | 7 | - | |
| $t_{\text{d(off)}}$ | Turn-off delay time | | - | 34 | - | |
| t_{f} | Fall time | | - | 13.5 | - | |

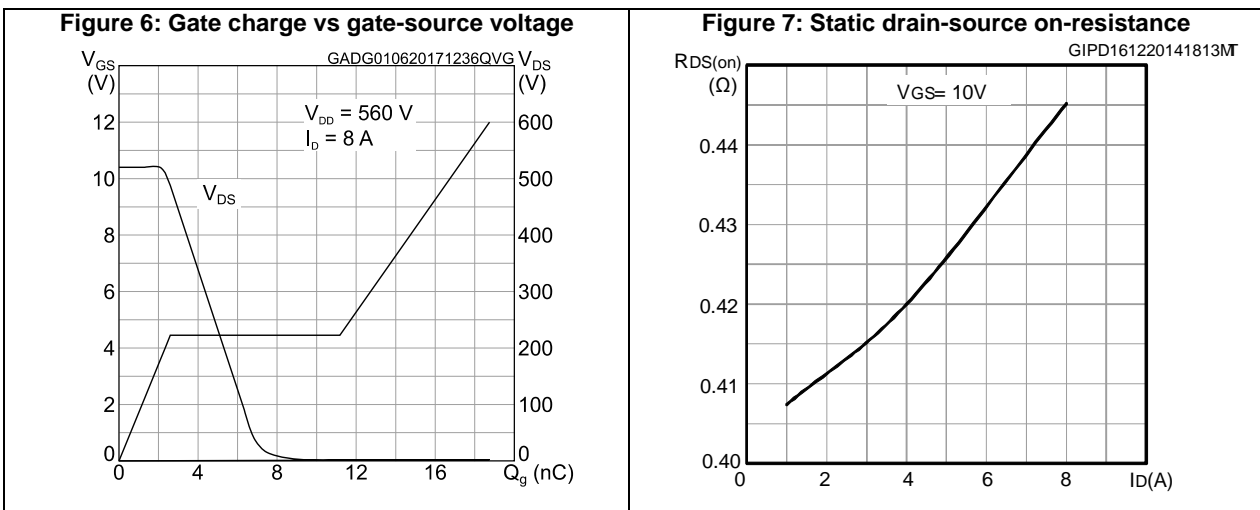
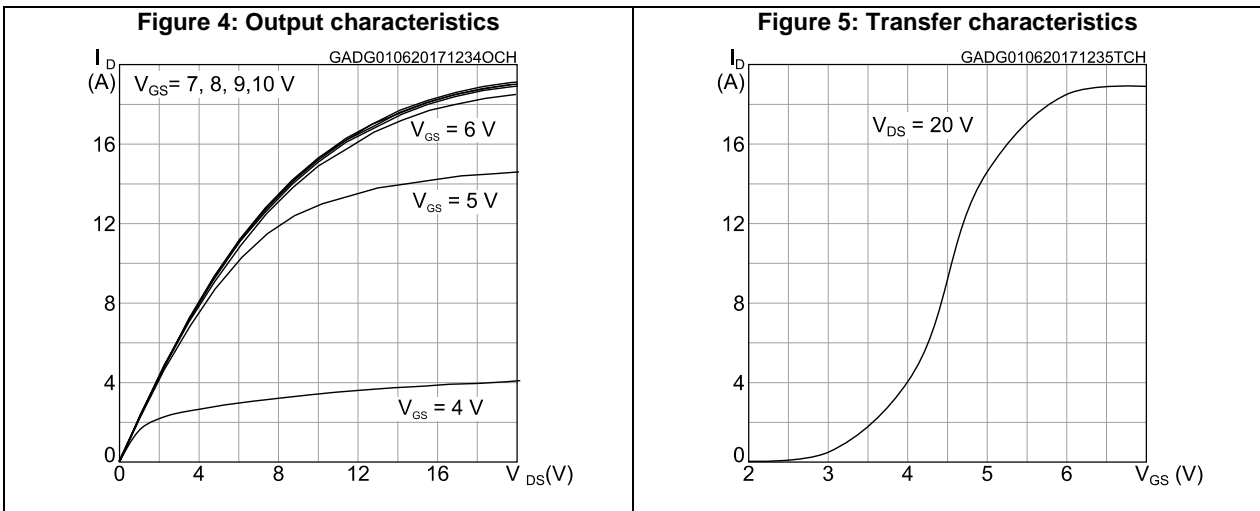
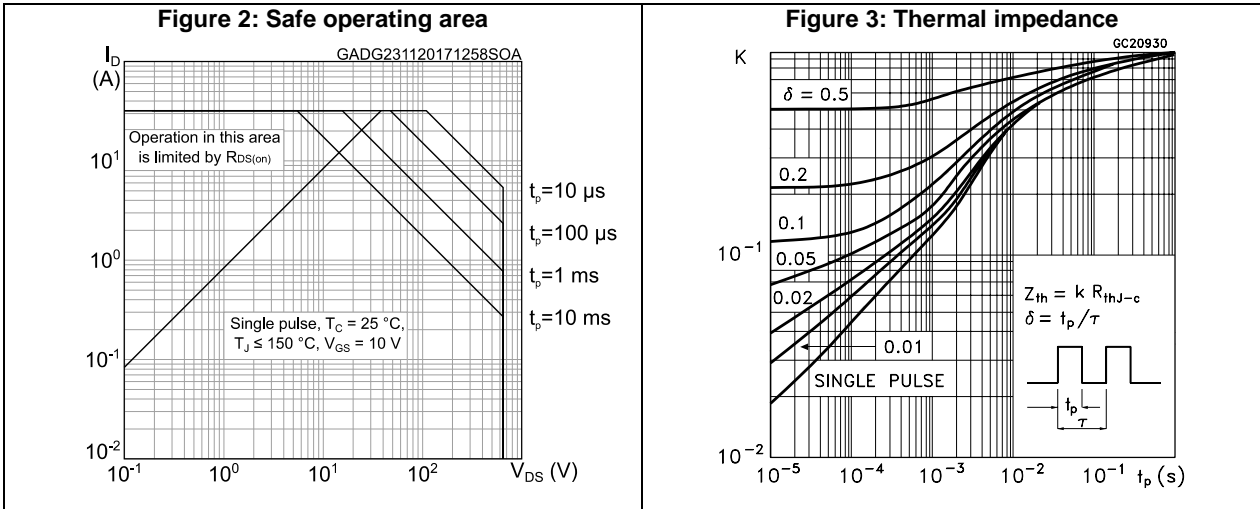
Table 8: Source-drain diode

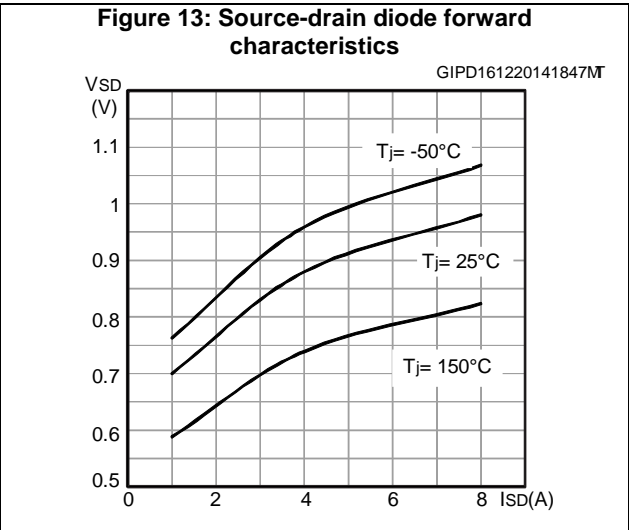
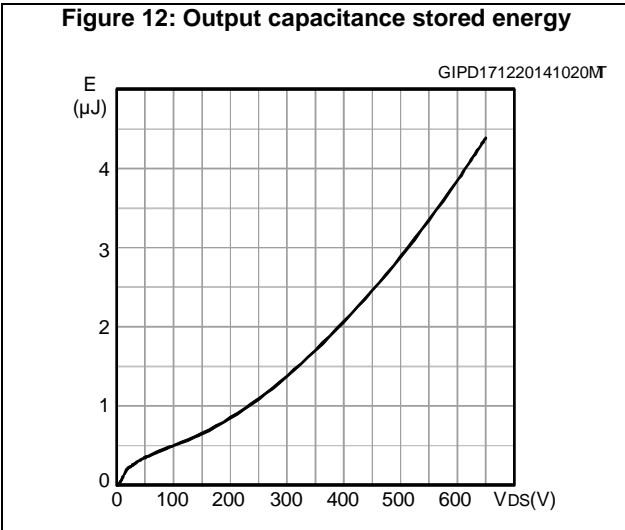
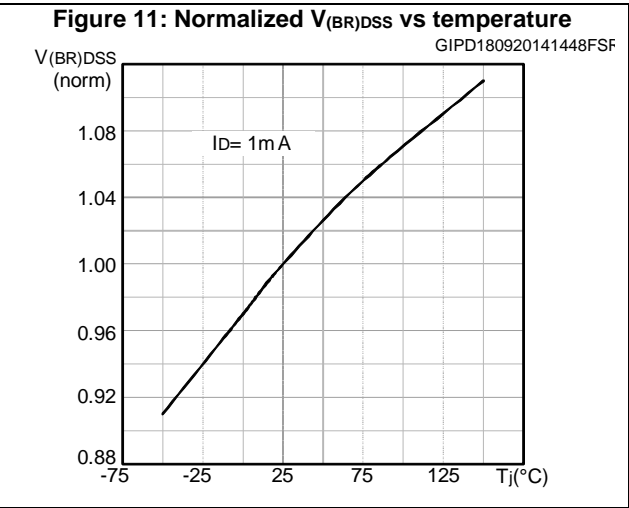
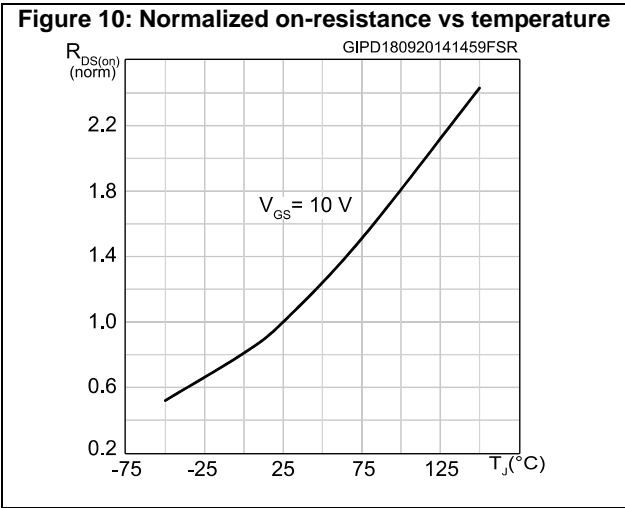
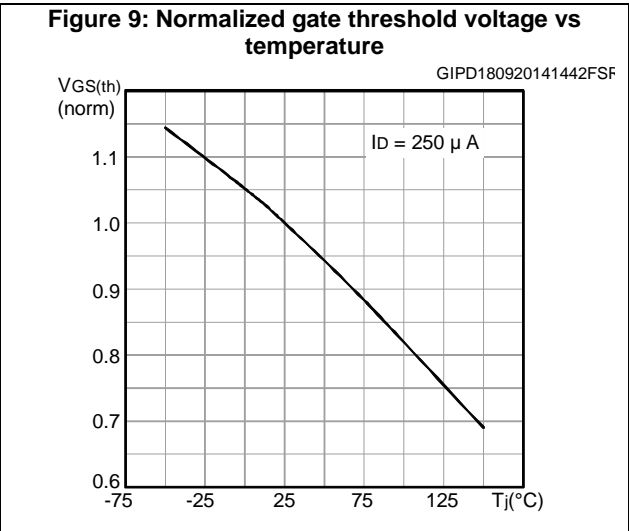
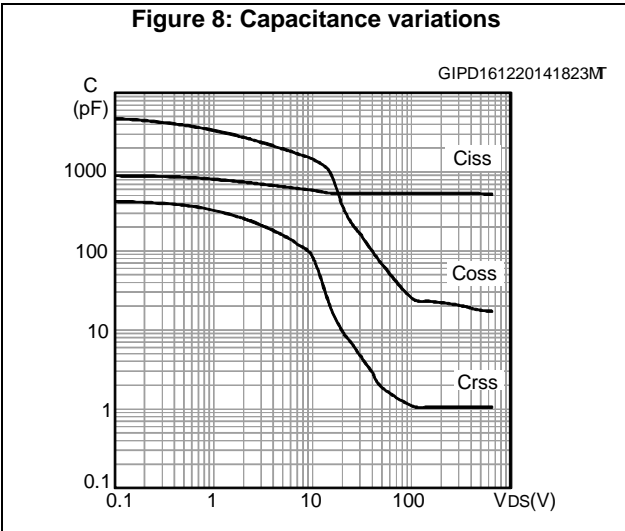
| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|--|------|------|------|---------------|
| $I_{SD}^{(1)}$ | Source-drain current | | - | | 8 | A |
| $I_{SDM}^{(2)}$ | Source-drain current (pulsed) | | - | | 32 | A |
| $V_{SD}^{(3)}$ | Forward on voltage | $V_{GS} = 0\text{ V}$, $I_{SD} = 8\text{ A}$ | - | | 1.6 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 8\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD} = 60\text{ V}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times") | - | 313 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 2.7 | | μC |
| I_{RRM} | Reverse recovery current | | - | 17 | | A |
| t_{rr} | Reverse recovery time | $I_{SD} = 8\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD} = 60\text{ V}$, $T_j = 150\text{ }^\circ\text{C}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times") | - | 462 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 4.1 | | μC |
| I_{RRM} | Reverse recovery current | | - | 17.5 | | A |

Notes:

- (1) Limited by package.
(2) Pulse width is limited by safe operating area.
(3) Pulse test: pulse duration = 300 μs , duty cycle 1.5%.

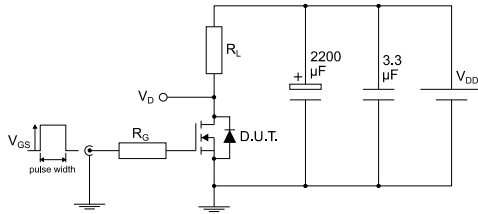
2.1 Electrical characteristics (curves)





3 Test circuits

Figure 14: Test circuit for resistive load switching times



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Figure 15: Test circuit for gate charge behavior



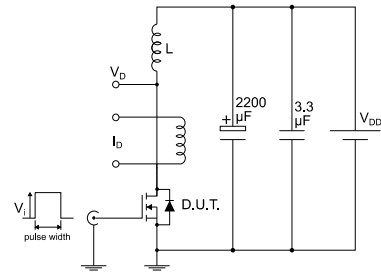
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Figure 16: Test circuit for inductive load switching and diode recovery times



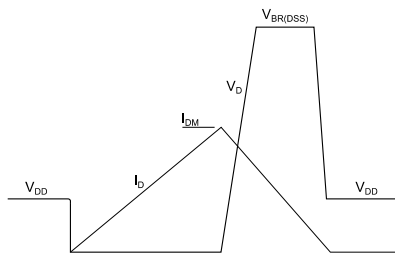
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Figure 17: Unclamped inductive load test circuit



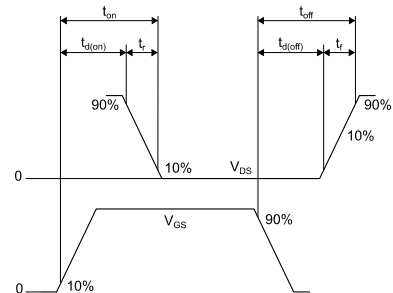
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Figure 18: Unclamped inductive waveform



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Figure 19: Switching time waveform



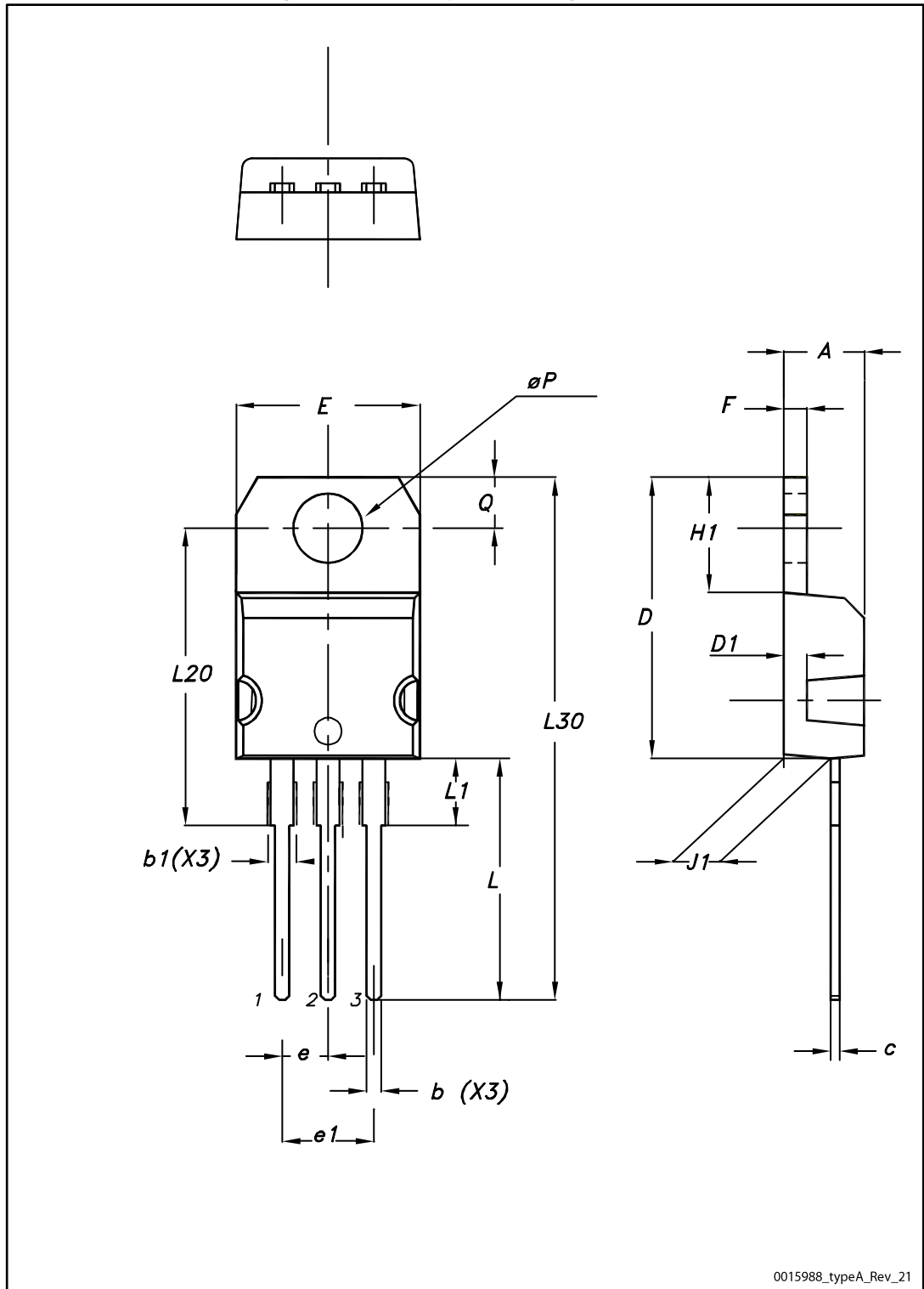
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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 TO-220 type A package information

Figure 20: TO-220 type A package outline



0015988_typeA_Rev_21

Table 9: TO-220 type A package mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.40 | | 4.60 |
| b | 0.61 | | 0.88 |
| b1 | 1.14 | | 1.55 |
| c | 0.48 | | 0.70 |
| D | 15.25 | | 15.75 |
| D1 | | 1.27 | |
| E | 10.00 | | 10.40 |
| e | 2.40 | | 2.70 |
| e1 | 4.95 | | 5.15 |
| F | 1.23 | | 1.32 |
| H1 | 6.20 | | 6.60 |
| J1 | 2.40 | | 2.72 |
| L | 13.00 | | 14.00 |
| L1 | 3.50 | | 3.93 |
| L20 | | 16.40 | |
| L30 | | 28.90 | |
| øP | 3.75 | | 3.85 |
| Q | 2.65 | | 2.95 |

5 Revision history

Table 10: Document revision history

| Date | Revision | Changes |
|-------------|----------|---------------|
| 28-Nov-2017 | 1 | First release |

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